

Notice of References Cited

Application/Control No.

10/056,637

Applicant(s)/Patent Under
Reexamination
ALEXANDER ET AL.

Examiner

Kim T. Huynh

Art Unit

2112

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0145147 A1	07-2003	Alexander et al.	710/260
	B	US-6,141,703 A	10-2000	Ding et al.	710/10
	C	US-5,615,389 A	03-1997	Mayfield et al.	710/8
	D	US-5,881,294 A	03-1999	Downey et al.	710/260
	E	US-2003/0115394 A1	06-2003	Kulchitsky et al.	710/260
	F	US-2002/0116563 A1	08-2002	Lever, Paul D.	710/260
	G	US-2003/0065856 A1	04-2003	Kagan et al.	710/263
	H	US-6,425,038 B1	07-2002	Sprecher, Reginald W.	710/269
	I	US-6,260,100 B1	07-2001	Kessler, Stephen Louis	710/260
	J	US-2003/0061423 A1	03-2003	Rankin et al.	710/260
	K	US-2003/0065856 A1	04-2003	Kagan et al.	710/263
	L	US-6,490,645 B1	12-2002	Shahaf et al.	710/244
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.